

	Hits	Search Text
1	1076	d13/112,115,179,184.ccls.
2	80	S39 and motor
3	29	S39 and generator
4	5400	conversion adj ratio
5	23	S43 and "702"/\$.ccls.
6	4	S44 and receiver
7	310	S43 and receiver
8	17	S46 and mixer and delay
9	55280	"375"/\$.ccls.
10	96	S48 and (conversion adj ratio)
11	5	S49 and mixer
12	602	velichko\$.in.
13	565	velichko
14	5	velichko and concurrently
15	49	semiconductor with manufactur\$ with supervis\$

	DBs
1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
5	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
6	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
7	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
8	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
9	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
10	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
11	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
12	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
13	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
14	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
15	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB

	Hits	Search Text
16	2	semiconductor with manufactur\$ with supervis\$ with (test or tested or testing)
17	5	("5838566"   "5859964"   "6208904"   "6240331").PN. OR ("6721618").URPN.
18	1	("6721618").PN.
19	3	S56 and (test or tested or testing)

	DBs
16	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB
17	US-PGPUB; USPAT; USOCR
18	US-PGPUB; USPAT; USOCR
19	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB